What is claimed is:

 A scanning microscope comprising at least one light source generating an illuminating light beam, an acousto-optical element for adjusting the optical power of the illuminating light beam, and further comprising a beam deflection device for scanning the illuminating light beam over or through a sample,

wherein the acousto-optical element spatially splits a sub-light beam from the illuminating light beam; and

beam guiding means are provided which direct the sub-light beam onto the sample, preferably to manipulate the same.

- The scanning microscope as recited in Claim 1,
 wherein the acousto-optical element includes an AOTF (acousto-optical tunable filter).
- The scanning microscope as recited in one of Claims 1 or 2, wherein a further beam deflection device is provided for scanning the sub-light beam over or through a sample.
- The scanning microscope as recited in one of Claims 1 through 3, wherein an objective lens is provided which focuses the illuminating light beam onto the sample.
- The scanning microscope as recited in Claim 4,
 wherein the objective lens focuses the sub-light beam onto the sample.
- The scanning microscope as recited in Claim 4,
 wherein a further objective lens is provided which focuses the sub-light beam onto the sample.
- The scanning microscope as recited in one of Claims 1 through 6, wherein the beam guiding means include an optical waveguide.
- 8. The scanning microscope as recited in one of Claims 1 through 7,

wherein the component that the acousto-optical element separates from the illuminating light beam as a sub-light beam is a component having a specific polarization property.

- The scanning microscope as recited in Claim 8, wherein a polarization-controlling means is disposed between the at least one light source and the acousto-optical element.
- The scanning microscope as recited in Claim 9,
 wherein the polarization-controlling means includes a λ/2 plate.
- 11. The scanning microscope as recited in one of Claims 1 through 10, wherein compensation means are provided which compensate for spatial spectral dispersion of the sub-light beam and/or illuminating light beam caused by the acousto-optical element.
- 12. The scanning microscope as recited in Claim 11, wherein the compensation means include a prism and/or a grating and/or a further acoustooptical element.
- 13. The scanning microscope as recited in one of Claims 1 through 12, wherein the acousto-optical element directs detection light emanating from the sample to a detector.
- 14. The scanning microscope as recited in one of Claims 1 through 13, wherein the scanning microscope is a confocal scanning microscope.